CMOS Digital Integrated Circuits Silicon Monolithic

74VHC165FT

1. Functional Description

- 8-Bit Shift Register (P-IN, S-OUT)

2. General

The 74VHC165FT is an advanced high speed CMOS 8-BIT PARALLEL/SERIAL-IN, SERIAL-OUT SHIFT REGISTER fabricated with silicon gate C^2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It consists of parallel-in or serial-in, serial-out 8-bit shift register with a gated clock input. When the SHIFT/$\overline{\text{LOAD}}$ input is held high, the serial data input is enabled and the eight frip-frops perform serial shifting with each clock pulse.

When the SHIFT/$\overline{\text{LOAD}}$ input is held low, the parallel data is loaded synchronously into the register at positive going transition of the clock pulse.

The CK-INH input should be shifted high only when the CK input is held high.

An Input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and on two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

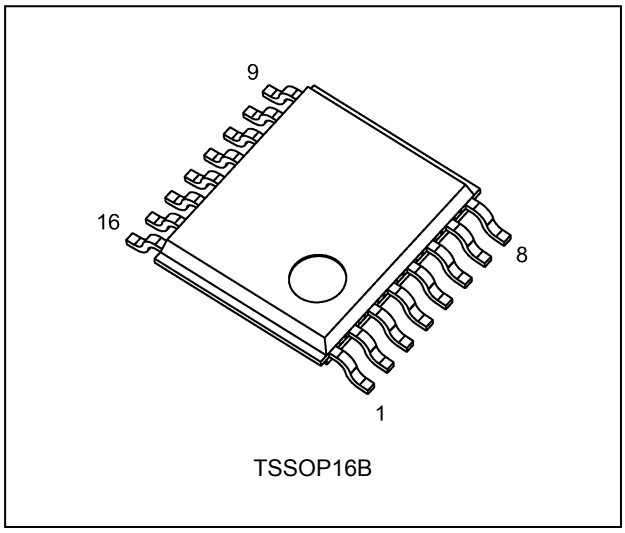
3. Features

(1) AEC-Q100 (Rev. H) (Note 1)
(2) Wide operating temperature range: T_{opr} = -40 to 125 °C
(3) High speed: f_{MAX} = 150 MHz (typ.) at V_{CC} = 5 V
(4) Low power dissipation: I_{CC} = 4.0 μA (max) at T_a = 25 °C
(5) High noise immunity: $V_{NIH} = V_{NIL}$ = 28 % V_{CC} (min)
(6) Power-down protection is provided on all inputs.
(7) Balanced propagation delays: $t_{PLH} \approx t_{PHL}$
(8) Wide operating voltage range: $V_{CC(opr)}$ = 2.0 V to 5.5 V
(9) Pin and function compatible with 74 series (74AC/HC/AHC etc.) 165 type.

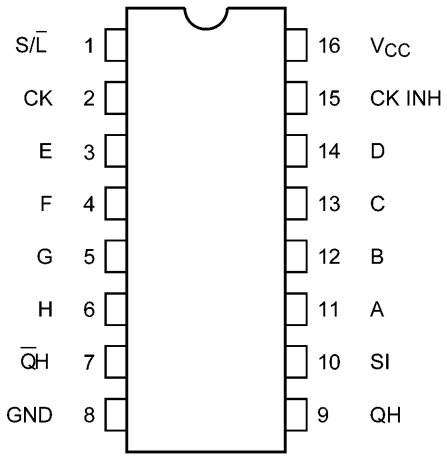
Note 1: This device is compliant with the reliability requirements of AEC-Q100. For details, contact your Toshiba sales representative.

Start of commercial production
2013-05

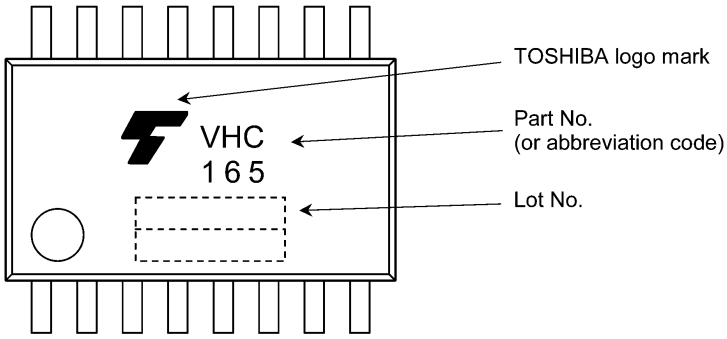
4. Packaging



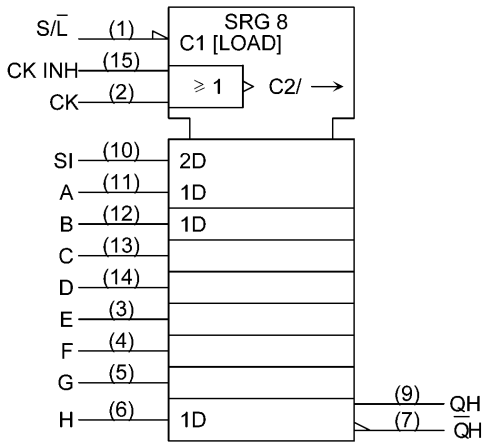
5. Pin Assignment



6. Marking



7. IEC Logic Symbol



8. Truth Table

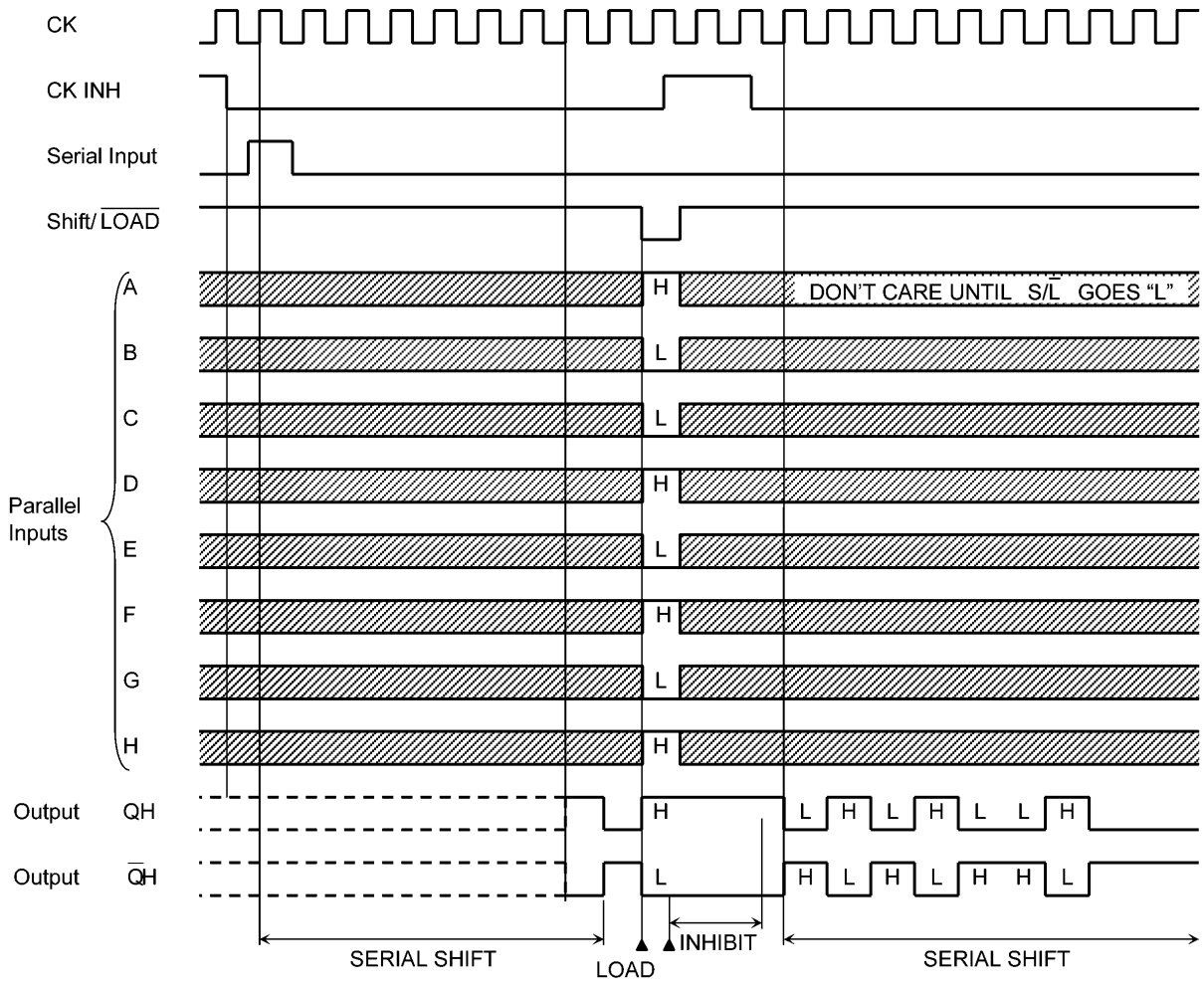
Inputs					Internal Outputs		Outputs	
SHIFT/$\overline{LOAD}$	CK INH	CK	SERIAL IN	PARALLEL A……H	QA	QB	QH	$\overline{QH}$
L	X	X	X	a……h	a	b	h	$\overline{h}$
H	L	↑	H	X	H	QA_n	QG_n	$\overline{QG}_n$
H	L	↑	L	X	L	QA_n	QG_n	$\overline{QG}_n$
H	↑	L	H	X	H	QA_n	QG_n	$\overline{QG}_n$
H	↑	L	L	X	L	QA_n	QG_n	$\overline{QG}_n$
H	X	H	X	X	No Change			
H	H	X	X	X	No Change			

X: Don't care

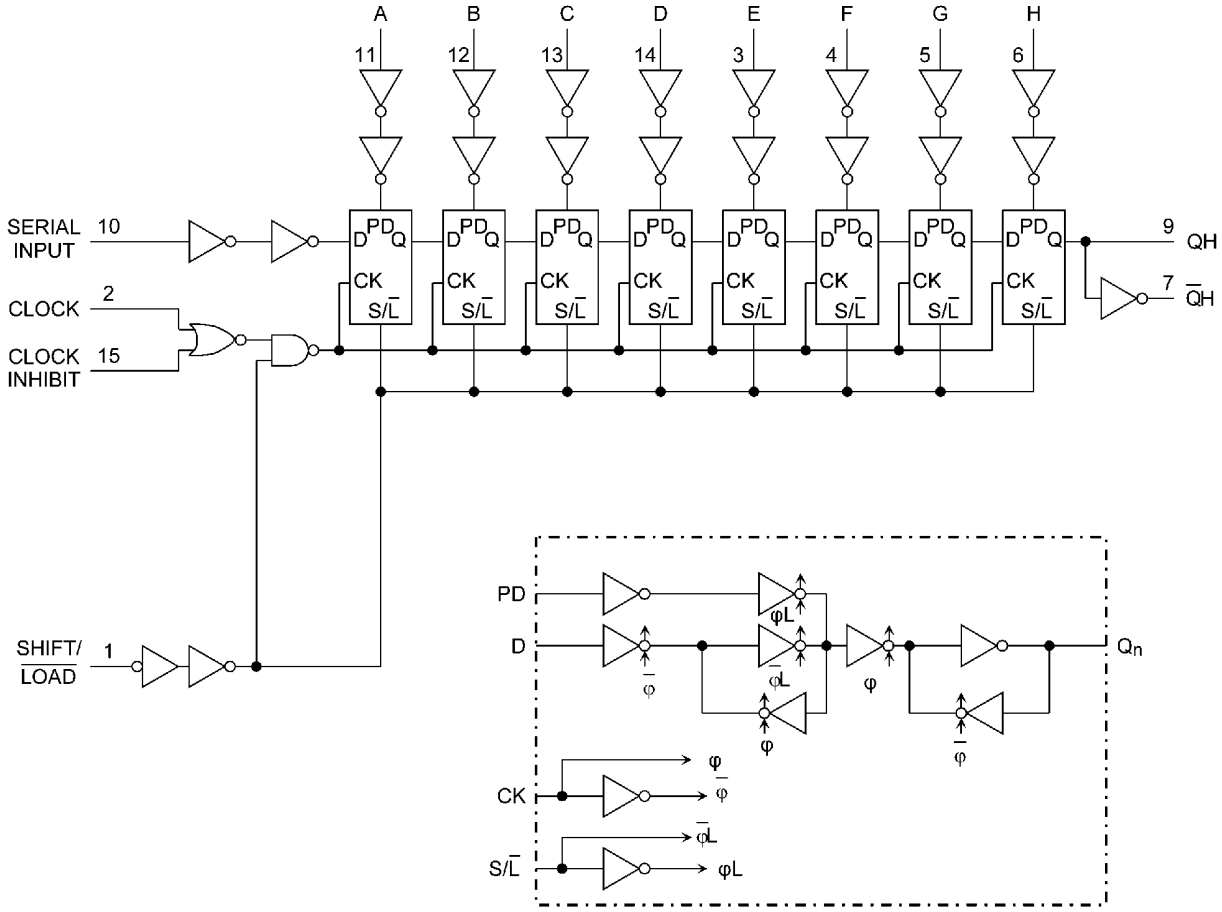
a.....h: The level of steady state input voltage at inputs A through H respectively.

QA_n to QG_n: The level of QA to QG, respectively, before the most recent positive transition of the CK.

9. Timing Diagrams



10. System Diagram



11. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V_{CC}		-0.5 to 7.0	V
Input voltage	V_{IN}		-0.5 to 7.0	V
Output voltage	V_{OUT}		-0.5 to V_{CC} + 0.5	V
Input diode current	I_{IK}		-20	mA
Output diode current	I_{OK}		±20	mA
Output current	I_{OUT}		±25	mA
V_{CC}/ground current	I_{CC}		±50	mA
Power dissipation	P_D	(Note 1)	180	mW
Storage temperature	T_{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/“Derating Concept and Methods”) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: 180 mW in the range of T_a = -40 to 85 °C. From T_a = 85 to 125 °C a derating factor of -3.25 mW/°C shall be applied until 50 mW.

12. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Rating	Unit
Supply voltage	V_{CC}		2.0 to 5.5	V
Input voltage	V_{IN}		0 to 5.5	V
Output voltage	V_{OUT}		0 to V_{CC}	V
Operating temperature	T_{opr}		-40 to 125	°C
Input rise and fall times	dt/dv	V_{CC} = 3.3 ± 0.3 V	0 to 100	ns/V
		V_{CC} = 5 ± 0.5 V	0 to 20	

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either V_{CC} or GND.

13. Electrical Characteristics

13.1. DC Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Test Condition		V_{CC} (V)	Min	Typ.	Max	Unit
High-level input voltage	V_{IH}	—		2.0	1.50	—	—	V
				3.0 to 5.5	V_{CC} × 0.7	—	—	
Low-level input voltage	V_{IL}	—		2.0	—	—	0.50	V
				3.0 to 5.5	—	—	V_{CC} × 0.3	
High-level output voltage	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = -50 μA	2.0	1.9	2.0	—	V
				3.0	2.9	3.0	—	
				4.5	4.4	4.5	—	
			I_{OH} = -4 mA	3.0	2.58	—	—	
			I_{OH} = -8 mA	4.5	3.94	—	—	
Low-level output voltage	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	2.0	—	0.0	0.1	V
				3.0	—	0.0	0.1	
				4.5	—	0.0	0.1	
			I_{OL} = 4 mA	3.0	—	—	0.36	
			I_{OL} = 8 mA	4.5	—	—	0.36	
Input leakage current	I_{IN}	V_{IN} = 5.5 V or GND		0 to 5.5	—	—	±0.1	μA
Quiescent supply current	I_{CC}	V_{IN} = V_{CC} or GND		5.5	—	—	4.0	μA

13.2. DC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C)

Characteristics	Symbol	Test Condition		V_{CC} (V)	Min	Max	Unit
High-level input voltage	V_{IH}	—		2.0	1.5	—	V
				3.0 to 5.5	V_{CC} × 0.7	—	
Low-level input voltage	V_{IL}	—		2.0	—	0.5	V
				3.0 to 5.5	—	V_{CC} × 0.3	
High-level output voltage	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = -50 μA	2.0	1.9	—	V
				3.0	2.9	—	
				4.5	4.4	—	
			I_{OH} = -4 mA	3.0	2.48	—	
			I_{OH} = -8 mA	4.5	3.80	—	
Low-level output voltage	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	2.0	—	0.1	V
				3.0	—	0.1	
				4.5	—	0.1	
			I_{OL} = 4 mA	3.0	—	0.44	
			I_{OL} = 8 mA	4.5	—	0.44	
Input leakage current	I_{IN}	V_{IN} = 5.5 V or GND		0 to 5.5	—	±1.0	μA
Quiescent supply current	I_{CC}	V_{IN} = V_{CC} or GND		5.5	—	40.0	μA

13.3. DC Characteristics (Unless otherwise specified, T_a = -40 to 125 °C)

Characteristics	Symbol	Test Condition		V_{CC} (V)	Min	Max	Unit
High-level input voltage	V_{IH}	—		2.0	1.50	—	V
				3.0 to 5.5	V_{CC} × 0.7	—	
Low-level input voltage	V_{IL}	—		2.0	—	0.50	V
				3.0 to 5.5	—	V_{CC} × 0.3	
High-level output voltage	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = -50 μA	2.0	1.9	—	V
				3.0	2.9	—	
				4.5	4.4	—	
			I_{OH} = -4 mA	3.0	2.40	—	
			I_{OH} = -8 mA	4.5	3.70	—	
Low-level output voltage	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	2.0	—	0.1	V
				3.0	—	0.1	
				4.5	—	0.1	
			I_{OL} = 4 mA	3.0	—	0.55	
			I_{OL} = 8 mA	4.5	—	0.55	
Input leakage current	I_{IN}	V_{IN} = 5.5 V or GND		0 to 5.5	—	±2.0	μA
Quiescent supply current	I_{CC}	V_{IN} = V_{CC} or GND		5.5	—	80.0	μA

13.4. Timing Requirements (Unless otherwise specified, T_a = 25 °C, Input: t_r = t_f = 3 ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK, CK INH)	$t_{w(L)}$,$t_{w(H)}$	—	3.3 ± 0.3	6.0	ns
			5.0 ± 0.5	4.0	
Minimum pulse width ($S/\overline{L}$)	$t_{w(L)}$	—	3.3 ± 0.3	7.5	ns
			5.0 ± 0.5	5.0	
Minimum setup time (PI-$S/\overline{L}$)	t_s	—	3.3 ± 0.3	7.5	ns
			5.0 ± 0.5	5.0	
Minimum setup time (SI-CK, CK INH)	t_s	—	3.3 ± 0.3	5.0	ns
			5.0 ± 0.5	4.0	
Minimum setup time ($S/\overline{L}$-CK, CK INH)	t_s	—	3.3 ± 0.3	5.0	ns
			5.0 ± 0.5	4.0	
Minimum hold time (PI-$S/\overline{L}$)	t_h	—	3.3 ± 0.3	0.5	ns
			5.0 ± 0.5	1.0	
Minimum hold time (SI-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum hold time ($S/\overline{L}$-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum removal time (CK INH-CK), (CK-CK INH)	t_{rem}	—	3.3 ± 0.3	5.0	ns
			5.0 ± 0.5	3.5	

13.5. Timing Requirements (Unless otherwise specified, T_a = -40 to 85 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK, CK INH)	$t_{w(L)}$,$t_{w(H)}$	—	3.3 ± 0.3	7.0	ns
			5.0 ± 0.5	4.0	
Minimum pulse width ($S/\overline{L}$)	$t_{w(L)}$	—	3.3 ± 0.3	9.0	ns
			5.0 ± 0.5	6.0	
Minimum setup time (PI-$S/\overline{L}$)	t_s	—	3.3 ± 0.3	8.5	ns
			5.0 ± 0.5	5.0	
Minimum setup time (SI-CK, CK INH)	t_s	—	3.3 ± 0.3	6.0	ns
			5.0 ± 0.5	4.0	
Minimum setup time ($S/\overline{L}$-CK, CK INH)	t_s	—	3.3 ± 0.3	6.0	ns
			5.0 ± 0.5	4.0	
Minimum hold time (PI-$S/\overline{L}$)	t_h	—	3.3 ± 0.3	0.5	ns
			5.0 ± 0.5	1.0	
Minimum hold time (SI-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum hold time ($S/\overline{L}$-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum removal time (CK INH-CK), (CK-CK INH)	t_{rem}	—	3.3 ± 0.3	5.0	ns
			5.0 ± 0.5	3.5	

13.6. Timing Requirements (Unless otherwise specified, T_a = -40 to 125 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK, CK INH)	$t_{w(L)}$,$t_{w(H)}$	—	3.3 ± 0.3	7.0	ns
			5.0 ± 0.5	4.0	
Minimum pulse width ($S/\overline{L}$)	$t_{w(L)}$	—	3.3 ± 0.3	9.0	ns
			5.0 ± 0.5	6.0	
Minimum setup time (PI-$S/\overline{L}$)	t_s	—	3.3 ± 0.3	8.5	ns
			5.0 ± 0.5	5.0	
Minimum setup time (SI-CK, CK INH)	t_s	—	3.3 ± 0.3	6.0	ns
			5.0 ± 0.5	4.0	
Minimum setup time ($S/\overline{L}$-CK, CK INH)	t_s	—	3.3 ± 0.3	6.0	ns
			5.0 ± 0.5	4.0	
Minimum hold time (PI-$S/\overline{L}$)	t_h	—	3.3 ± 0.3	0.5	ns
			5.0 ± 0.5	1.0	
Minimum hold time (SI-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum hold time ($S/\overline{L}$-CK, CK INH)	t_h	—	3.3 ± 0.3	0.0	ns
			5.0 ± 0.5	0.5	
Minimum removal time (CK INH-CK), (CK-CK INH)	t_{rem}	—	3.3 ± 0.3	5.0	ns
			5.0 ± 0.5	3.5	

13.7. AC Characteristics (Unless otherwise specified, T_a = 25 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Note	Test Condition	V_{CC} (V)	C_L (pF)	Min	Typ.	Max	Unit
Propagation delay time (CK, CK INH-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}		—	3.3 ± 0.3	15	—	9.9	15.4	ns
					50	—	12.4	18.9	
				5.0 ± 0.5	15	—	6.6	9.9	
					50	—	8.1	11.9	
Propagation delay time (S/$\overline{L}$-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}		—	3.3 ± 0.3	15	—	9.9	15.8	ns
					50	—	12.4	19.3	
				5.0 ± 0.5	15	—	6.7	9.9	
					50	—	8.2	11.9	
Propagation delay time (H-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}		—	3.3 ± 0.3	15	—	9.2	14.1	ns
					50	—	11.7	17.6	
				5.0 ± 0.5	15	—	5.9	9.0	
					50	—	7.4	11.0	
Maximum clock frequency	f_{MAX}		—	3.3 ± 0.3	15	65	85	—	MHz
					50	60	105	—	
				5.0 ± 0.5	15	110	150	—	
					50	95	130	—	
Input capacitance	C_{IN}		—			—	4	10	pF
Power dissipation capacitance	C_{PD}	(Note 1)	—			—	50	—	pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}$

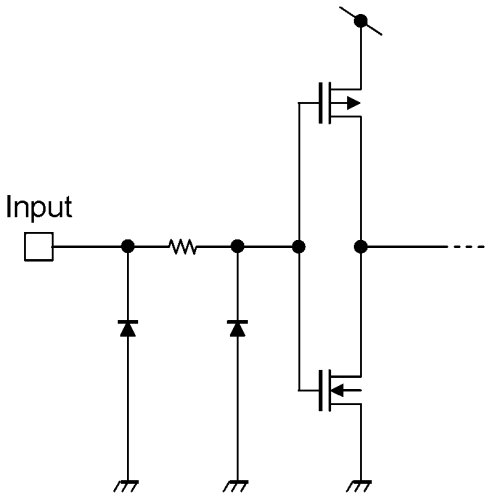
13.8. AC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	C_L (pF)	Min	Max	Unit
Propagation delay time (CK, CK INH-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	18.0	ns
				50	1.0	21.5	
			5.0 ± 0.5	15	1.0	11.5	
				50	1.0	13.5	
Propagation delay time (S/$\overline{L}$-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	18.5	ns
				50	1.0	22.0	
			5.0 ± 0.5	15	1.0	11.5	
				50	1.0	13.5	
Propagation delay time (H-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	16.5	ns
				50	1.0	20.0	
			5.0 ± 0.5	15	1.0	10.5	
				50	1.0	12.5	
Maximum clock frequency	f_{MAX}	—	3.3 ± 0.3	15	55	—	MHz
				50	50	—	
			5.0 ± 0.5	15	90	—	
				50	85	—	
Input capacitance	C_{IN}	—			—	10	pF

13.9. AC Characteristics
(Unless otherwise specified, T_a = -40 to 125 °C, Input: $t_r = t_f$ = 3 ns)

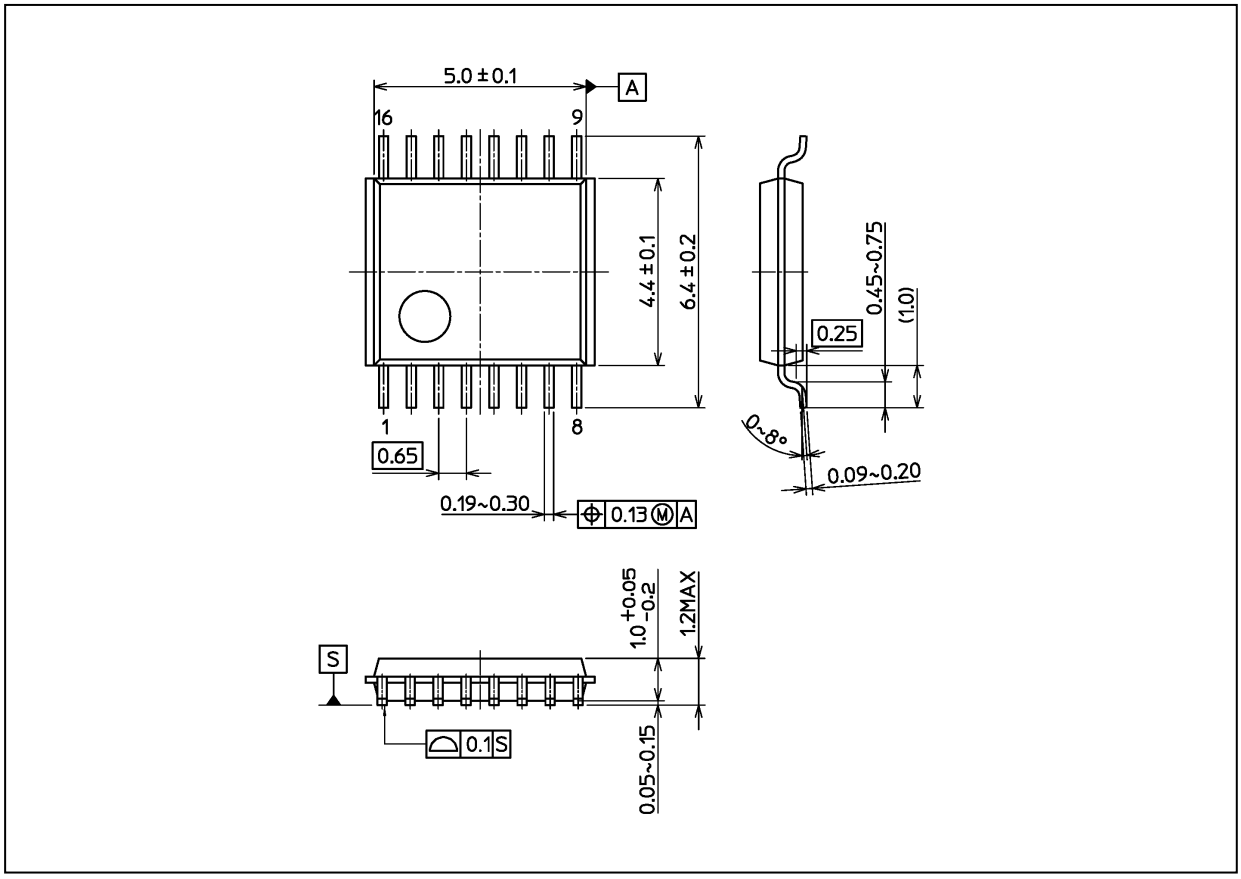
Characteristics	Symbol	Test Condition	V_{CC} (V)	C_L (pF)	Min	Max	Unit
Propagation delay time (CK, CK INH-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	20.5	ns
				50	1.0	24.0	
			5.0 ± 0.5	15	1.0	13.0	
				50	1.0	15.0	
Propagation delay time (S/L-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	21.0	ns
				50	1.0	24.5	
			5.0 ± 0.5	15	1.0	13.0	
				50	1.0	15.0	
Propagation delay time (H-QH, $\overline{Q}$H)	t_{PLH},t_{PHL}	—	3.3 ± 0.3	15	1.0	18.5	ns
				50	1.0	22.0	
			5.0 ± 0.5	15	1.0	12.0	
				50	1.0	14.0	
Maximum clock frequency	f_{MAX}	—	3.3 ± 0.3	15	50	—	MHz
				50	45	—	
			5.0 ± 0.5	15	85	—	
				50	75	—	
Input capacitance	C_{IN}	—			—	10	pF

14. Internal Equivalent Circuit



Package Dimensions

Unit: mm



Weight: 0.055 g (typ.)

Package Name(s)
Nickname: TSSOP16B

RESTRICTIONS ON PRODUCT USE

- Toshiba Corporation, and its subsidiaries and affiliates (collectively "TOSHIBA"), reserve the right to make changes to the information in this document, and related hardware, software and systems (collectively "Product") without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. **TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.**
- **PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT ("UNINTENDED USE").** Except for specific applications as expressly stated in this document, Unintended Use includes, without limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, medical equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions, safety devices, elevators and escalators, devices related to electric power, and equipment used in finance-related fields. **IF YOU USE PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT.** For details, please contact your TOSHIBA sales representative.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- **ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.**
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. **TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.**